### January 2004





# FDZ5047N

# 30V N-Channel Logic Level PowerTrench<sup>®</sup> BGA MOSFET

# **General Description**

Combining Fairchild's 30V PowerTrench process with state of the art BGA packaging, the FDZ5047N minimizes both PCB space and  $R_{DS(ON)}$ . This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultra-low profile packaging, low gate charge, and low  $R_{DS(ON)}$ .

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable  $R_{DS(ON)}$  specifications resulting in DC/DC power supply designs with higher overall efficiency.

### Applications

- DC/DC converters
- Solenoid drive

## Features

- 22 A, 30 V.  $R_{DS(ON)} = 2.9 \text{ m}\Omega @ V_{GS} = 10 \text{ V}$  $R_{DS(ON)} = 4.5 \text{ m}\Omega @ V_{GS} = 4.5 \text{ V}$
- Occupies only 27.5 mm<sup>2</sup> of PCB area: 1/5 of the area of a TO-220 package
- Ultra-thin package: less than 0.90 mm height when mounted to PCB
- Outstanding thermal transfer characteristics
- Ultra-low gate charge x R<sub>DS(ON)</sub> product
- $\begin{array}{c|c} \hline 0 & 0 & 0 & 0 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 8 & 8 & 8 & 0 \\ \hline 0 & 6 & 8 & 8 & 0 \\ \hline \end{array}$

# Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units		
V <sub>DSS</sub>	Drain-Source Voltage			30	V	
V <sub>GSS</sub>	Gate-Source Voltage			±20		
ID	Drain Curren	nt – Continuous	(Note 1a)	22	А	
	– Pulsed			75		
P <sub>D</sub>	Total Power	Total Power Dissipation @ $T_A = 25^{\circ}C$		2.8	W	
<del>-</del> -	Operating and Storage Junction Temperature Range			–50 to +150		
		0			O°	
Therma	l Charact	0		44	°C/W	
Therma R <sub>0JA</sub>	I Charact	eristics	mbient (Note 1a)			
$T_{J}, T_{STG}$ <b>Therma</b> $R_{0JA}$ $R_{0JB}$ $R_{0JC}$	I Charact Thermal Res Thermal Res	eristics sistance, Junction-to-A	mbient (Note 1a) all (Note 1)	44		
<b>Therma</b> R <sub>θJA</sub> R <sub>θJB</sub> R <sub>θJC</sub>	I Charact Thermal Res Thermal Res Thermal Res	eristics sistance, Junction-to-A sistance, Junction-to-B	mbient (Note 1a) all (Note 1) ase (Note 1)	44 2.7		
Therma <sub>Rөла</sub> Rөлв Rөлс Packag	I Charact Thermal Res Thermal Res Thermal Res	eristics sistance, Junction-to-A sistance, Junction-to-B sistance, Junction-to-C	mbient (Note 1a) all (Note 1) ase (Note 1)	44 2.7		

©2004 Fairchild Semiconductor Corporation.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics	1				
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	30			V
<u>ΔBVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		24		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 V$ , $V_{GS} = 0 V$			1	μA
I <sub>GSSF</sub>	Gate–Body Forward Leakage	$V_{GS} = 20 V, V_{DS} = 0 V$			100	nA
	Gate–Body Reverse Leakage	$V_{GS} = -20 V$ , $V_{DS} = 0 V$			-100	nA
On Char	acteristics (Note 2)	•		•		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	1	1.3	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		-5		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance			2.3 3.2 3.4	2.9 4.5 5.0	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 V$ , $I_{D} = 22 A$		100		S
Dynamic	c Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 V$ , $V_{GS} = 0 V$ ,		4993		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		1144		pF
C <sub>rss</sub>	Reverse Transfer Capacitance	7		498		pF
Switchin	ng Characteristics (Note 2)	•				
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DD} = 15 V$ , $I_D = 1 A$ ,	1	11	20	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS}$ = 10 V, $R_{GEN}$ = 6 $\Omega$		12	22	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			119	190	ns
t <sub>f</sub>	Turn–Off Fall Time	-		55	88	ns
Qg	Total Gate Charge	$V_{DS} = 15 V$ , $I_D = 22 A$ ,		52	73	nC
Q <sub>gs</sub>	Gate-Source Charge	$-V_{GS} = 5 V$		11		nC
Q <sub>gd</sub>	Gate–Drain Charge	7		17		nC
Drain-S	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				2.3	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 2.3 A$ (Note 2)		0.7	1.2	V
t <sub>rr</sub>	Diode Reverse Recovery Time	I <sub>F</sub> = 22A,		42		nS
Q <sub>rr</sub>	Diode Reverse Recovery Charge	d <sub>iF</sub> /d <sub>t</sub> = 100 A/µs		59		nC

1. R<sub>8JA</sub> is determined with the device mounted on a 1 in<sup>2</sup> 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball,  $R_{\theta JB}$ , is defined for reference. For  $R_{\theta JC}$ , the thermal reference point for the case is defined as the top surface of the copper chip carrier.  $\rm R_{_{0JC}}$  and  $\rm R_{_{0JB}}$  are guaranteed by design while  $\rm R_{_{0JA}}$  is determined by the user's board design.



44°C/W when mounted on a 1in<sup>2</sup> pad of 2 oz copper a)

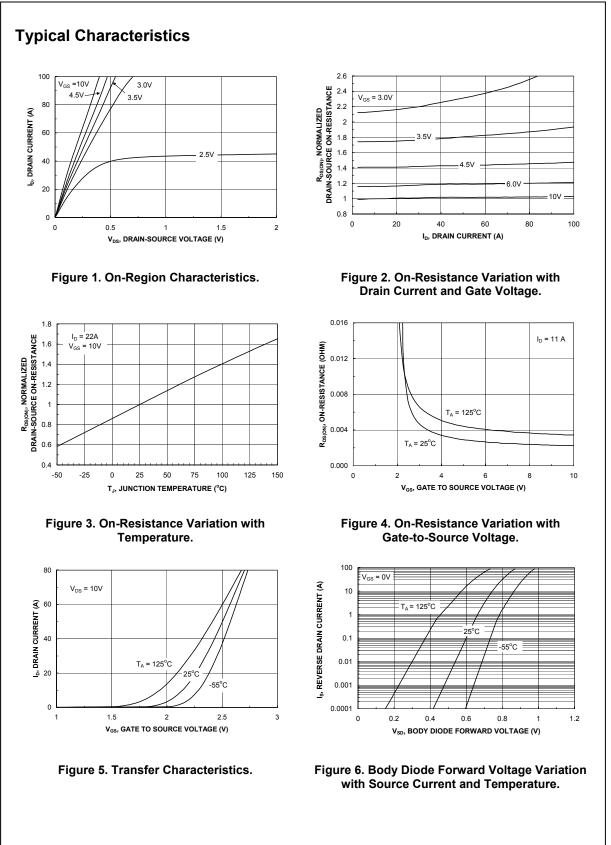


b) 95°C/W when mounted on a minimum pad of 2 oz copper

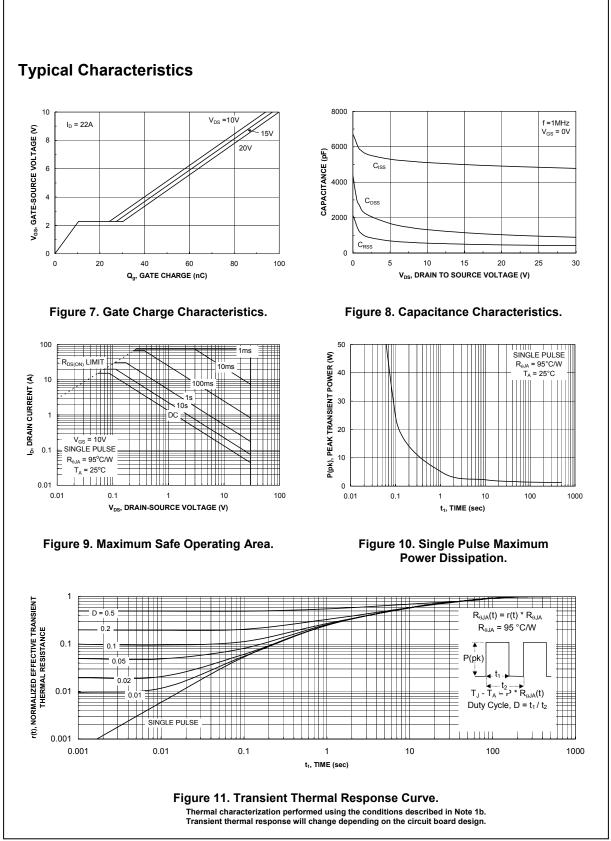
Scale 1 : 1 on letter size paper 2. Pulse Test: Pulse Width < 300  $\mu s,$  Duty Cycle < 2.0%

FDZ5047N Rev D4 (W)

FDZ5047N

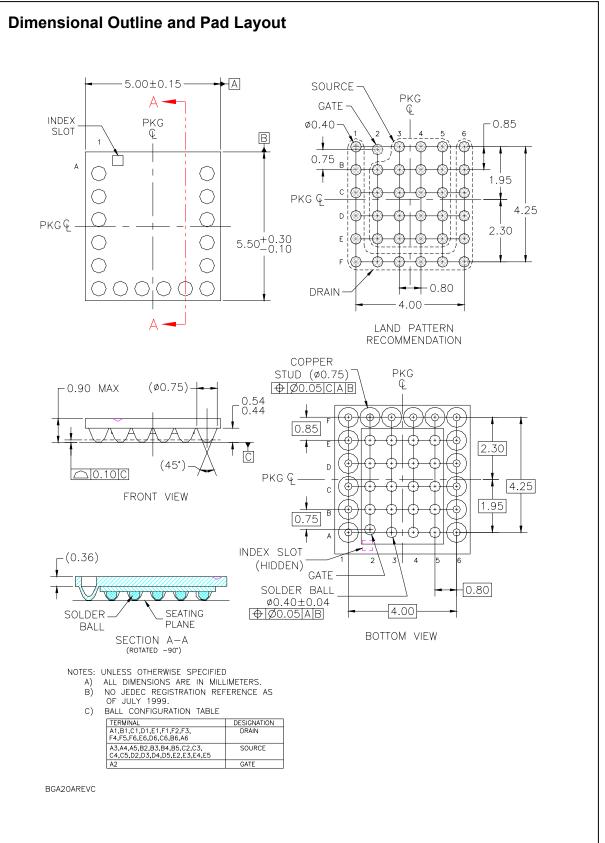


FDZ5047N



# FDZ5047N

FDZ5047N Rev D4 (W)



# FDZ5047N

FDZ5047N Rev D4 (W)

### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACExTMFACT Quiet SeriesTMActiveArrayTMFAST®BottomlessTMFASTrTMCoolFETTMFPSTMCROSSVOLTTMFRFETTMDOMETMGlobalOptoisolatorTMEcoSPARKTMGTOTME²CMOSTMHiSeCTMEnSignaTM $PCTM$ FACTTMImpliedDisconnectTMAcross the board. Around the world.TMThe Power FranchiseTMProgrammable Active DroopTM	$ISOPLANAR^{TM}$ $LittleFET^{TM}$ $MICROCOUPLER^{TM}$ $MicroFET^{TM}$ $MicroPak^{TM}$ $MICROWIRE^{TM}$ $MSX^{TM}$ $MSXPro^{TM}$ $OCX^{TM}$ $OCXPro^{TM}$ $OCXPro^{TM}$ $OPTOLOGIC^{(B)}$ $OPTOPLANAR^{TM}$ $PACMAN^{TM}$	POP <sup>TM</sup> Power247 <sup>TM</sup> PowerTrench <sup>®</sup> QFET <sup>®</sup> QS <sup>TM</sup> QT Optoelectronics <sup>TM</sup> Quiet Series <sup>TM</sup> RapidConfigure <sup>TM</sup> RapidConnect <sup>TM</sup> SILENT SWITCHER <sup>®</sup> SMART START <sup>TM</sup> SPM <sup>TM</sup> Stealth <sup>TM</sup>	SuperFET <sup>TM</sup> SuperSOT <sup>TM</sup> -3 SuperSOT <sup>TM</sup> -6 SuperSOT <sup>TM</sup> -8 SyncFET <sup>TM</sup> TinyLogic <sup>®</sup> TINYOPTO <sup>TM</sup> TruTranslation <sup>TM</sup> UHC <sup>TM</sup> UltraFET <sup>®</sup> VCX <sup>TM</sup>
---	--	---	---

### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

**Definition of Terms** 

Product Status	Definition
Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.
	Formative or In Design First Production Full Production